Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
09/473,558	CHIOU, BIN CHI
Examiner	Art Unit
Raj K. Jain	2616

SEARCHED					
Class	Subclass	Date	Examiner		
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INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)					
DATE	EXMR				
7/17/2006	RJ				
7/17/2006	RJ				
	DATE 7/17/2006				